

Dual N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY			
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^d	Q _g (Typ.)
60	0.0125 at V _{GS} = 10 V	16	16.5 nC
	0.018 at V _{GS} = 4.5 V	12	

FEATURES

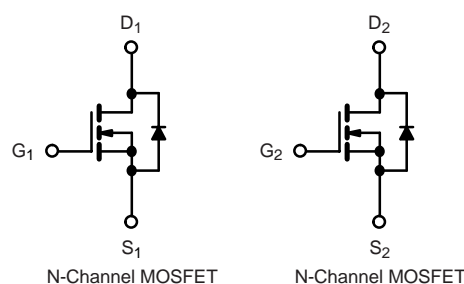
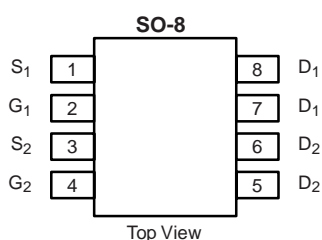
- DT-Trench Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested



RoHS
COMPLIANT

APPLICATIONS

- System power DC/DC



ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)			
PARAMETER	SYMBOL	LIMIT	UNIT
Drain-source voltage	V _{DS}	60	V
Gate-source voltage	V _{GS}	± 20	
Continuous drain current (T _J = 150 °C)	I _D	T _C = 25 °C	16 ^a
		T _C = 70 °C	11 ^a
		T _A = 25 °C	8 ^a
		T _A = 70 °C	4.5 ^a
Pulsed drain current	I _{DM}	112	A
Source-drain current diode current	I _S	T _C = 25 °C	
		T _A = 25 °C	3 ^{b, c}
Maximum power dissipation	P _D	T _C = 25 °C	25
		T _C = 70 °C	16
		T _A = 25 °C	2.6 ^{b, c}
		T _A = 70 °C	1.5 ^{b, c}
Operating junction and storage temperature range	T _J , T _{stg}	-55 to +150	°C
Soldering recommendations (peak temperature)		260	

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	TYP.	MAX.	UNIT
Maximum junction-to-ambient ^{b, d}	t ≤ 10 s	R _{thJA}	20	35	°C/W
Maximum junction-to-case (drain)	Steady state	R _{thJC}	3.5	5	

Notes

- Package limited
- Surface mounted on 1" x 1" FR4 board
- t = 10 s
- Maximum under steady state conditions is 80 °C/W

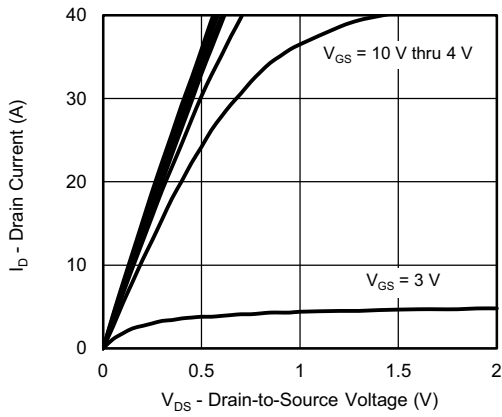
SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	60	-	-	V
V_{DS} temperature coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$	-	38	-	mV/ $^\circ\text{C}$
$V_{GS(th)}$ temperature coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250\text{ }\mu\text{A}$	-	-4.9	-	
Gate threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	1.0	-	3.0	V
Gate-body leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$	-	-	100	nA
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 48\text{ V}, V_{GS} = 0\text{ V}$	-	-	1	μA
		$V_{DS} = 48\text{ V}, V_{GS} = 0\text{ V}, T_J = 85\text{ }^\circ\text{C}$	-	-	10	
On-state drain current ^b	$I_{D(on)}$	$V_{DS} \geq 5\text{ V}, V_{GS} = 10\text{ V}$	16	-	-	A
Drain-source on-state resistance ^b	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 8\text{ A}$	-	0.0125	0.016	Ω
		$V_{GS} = 4.5\text{ V}, I_D = 6\text{ A}$	-	0.018	0.025	
Forward transconductance ^b	g_{fs}	$V_{DS} = 30\text{ V}, I_D = 8\text{ A}$	-	38	-	S
Dynamic ^a						
Input capacitance	C_{iss}	$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	-	1050	-	pF
Output capacitance	C_{oss}		-	235	-	
Reverse transfer capacitance	C_{rss}		-	20	-	
Total gate charge	Q_g	$V_{DS} = 30\text{ V}, V_{GS} = 10\text{ V}, I_D = 8\text{ A}$	-	16.5	-	nC
		$V_{DS} = 30\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 6\text{ A}$	-	7.8	-	
Gate-source charge	Q_{gs}	$V_{DS} = 30\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 6\text{ A}$	-	3.4	-	nC
Gate-drain charge	Q_{gd}		-	1.3	-	
Gate resistance	R_g		$f = 1\text{ MHz}$	-	5.0	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 30\text{ V}, R_L = 3.45\text{ }\Omega$ $I_D \cong 6.0\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\text{ }\Omega$	-	15	-	ns
Rise time	t_r		-	40	-	
Turn-off delay time	$t_{d(off)}$		-	17	-	
Fall time	t_f		-	35	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 30\text{ V}, R_L = 3.45\text{ }\Omega$ $I_D \cong 8.0\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\text{ }\Omega$	-	8	-	
Rise time	t_r		-	20	-	
Turn-off delay time	$t_{d(off)}$		-	10	-	
Fall time	t_f		-	19	-	
Drain-Source Body Diode Characteristics						
Continuous source-drain diode Current	I_S	$T_C = 25\text{ }^\circ\text{C}$	-	-	16	A
Pulse diode forward current ^a	I_{SM}		-	-	112	
Body diode voltage	V_{SD}	$I_S = 8.0\text{ A}$	-	0.7	1.2	V
Body diode reverse recovery time	t_{rr}	$I_F = 8.7\text{ A}, di/dt = 100\text{ A}/\mu\text{s},$ $T_J = 25\text{ }^\circ\text{C}$	-	35	53	ns
Body diode reverse recovery charge	Q_{rr}		-	30	40	nC
Reverse recovery fall time	t_a		-	11	-	ns
Reverse recovery rise time	t_b		-	18	-	

Notes

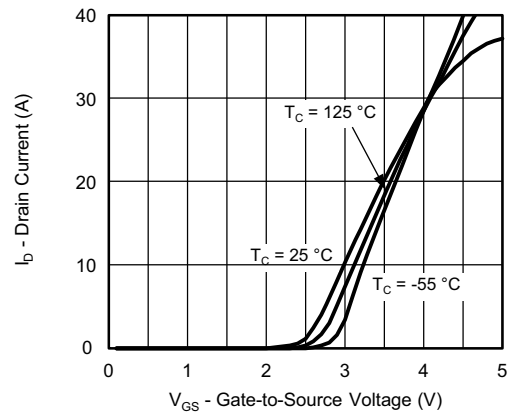
- a. Guaranteed by design, not subject to production testing
- b. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

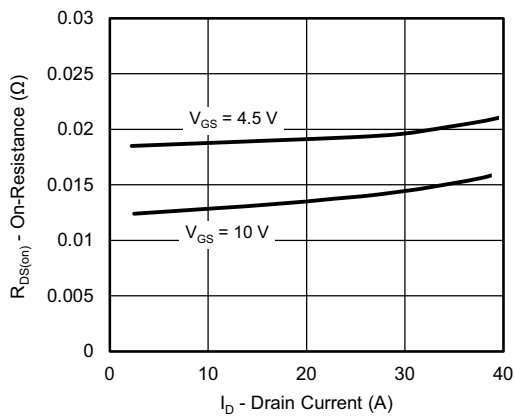
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



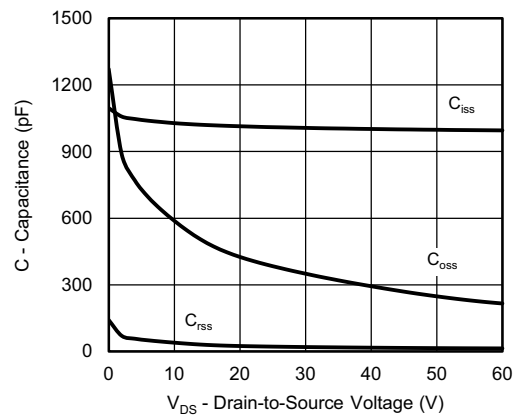
Output Characteristics



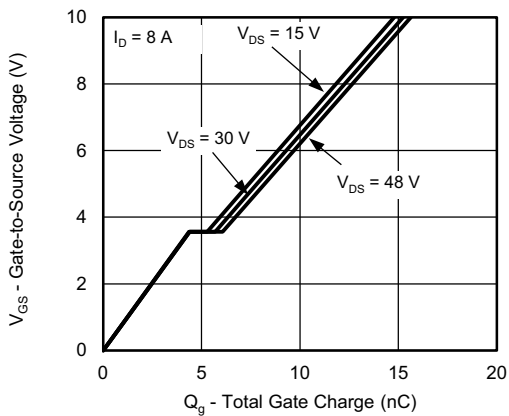
Transfer Characteristics



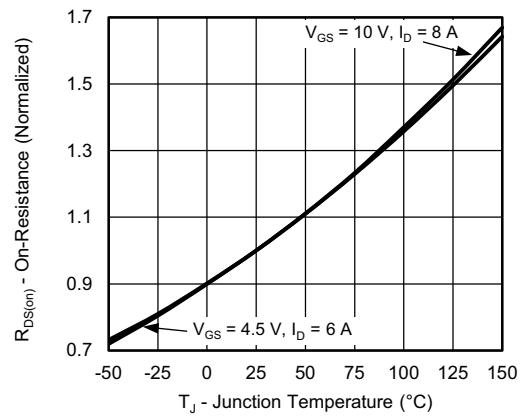
On-Resistance vs. Drain Current



Capacitance

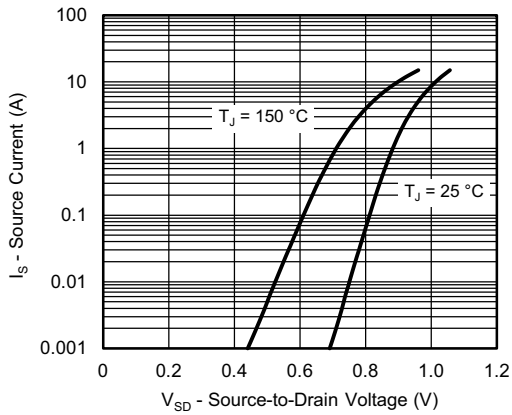


Gate Charge

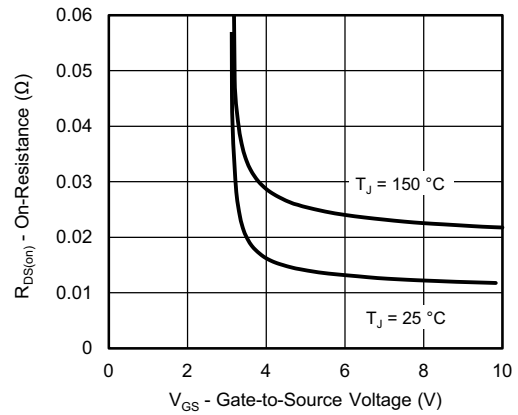


On-Resistance vs. Junction Temperature

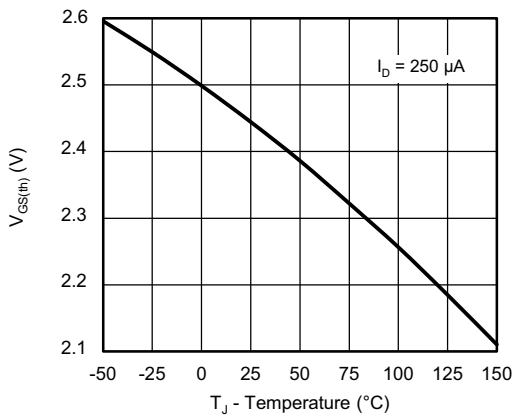
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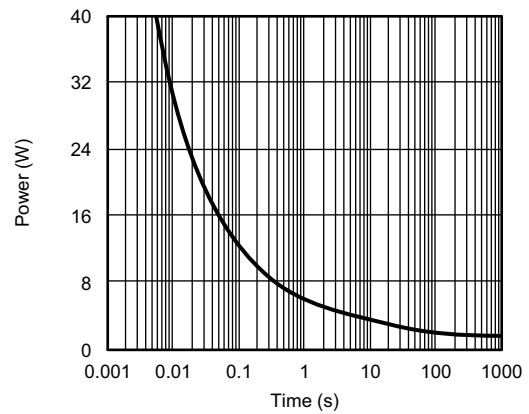
Source-Drain Diode Forward Voltage



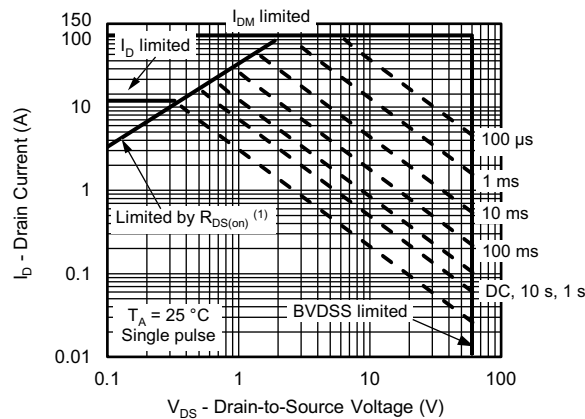
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



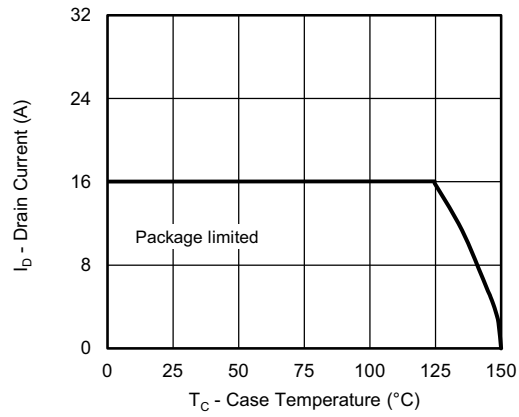
Single Pulse Power



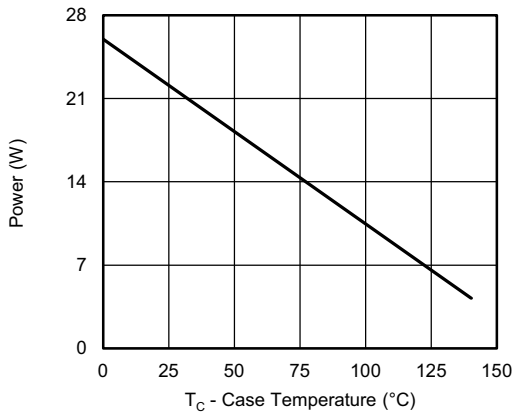
Safe Operating Area, Junction-to-Ambient

(1) $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

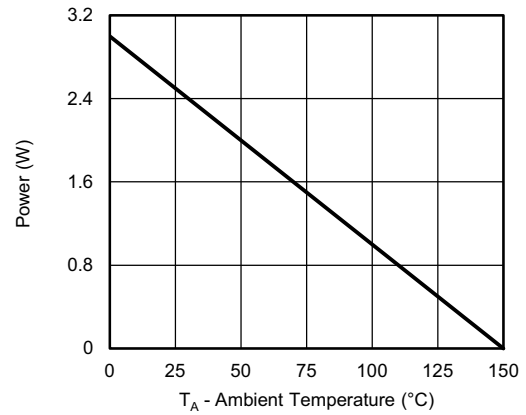
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating ^a



Power, Junction-to-Case

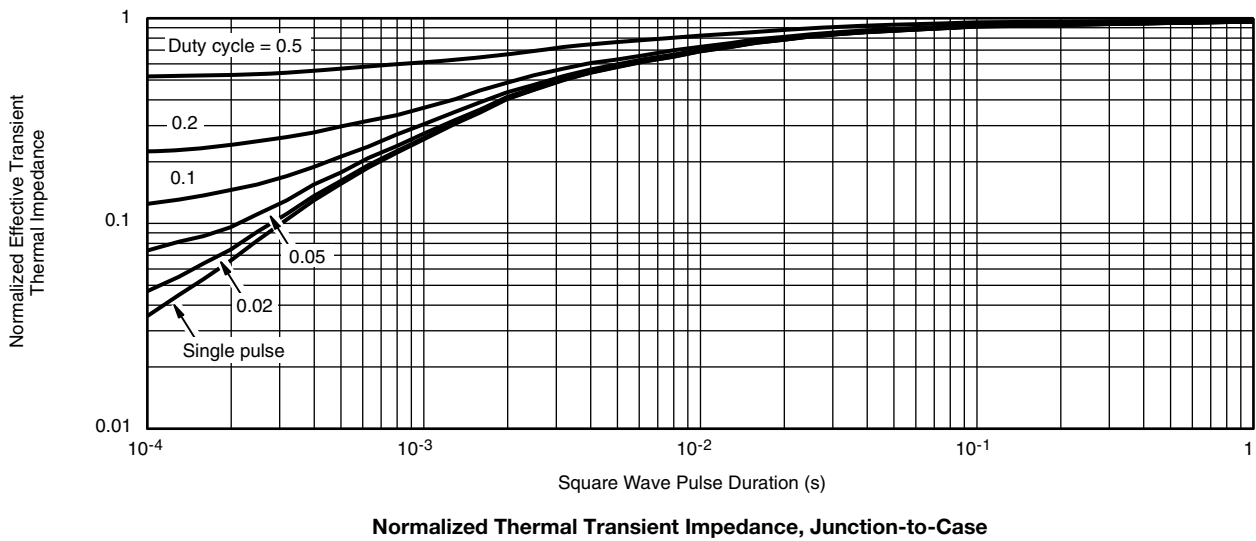
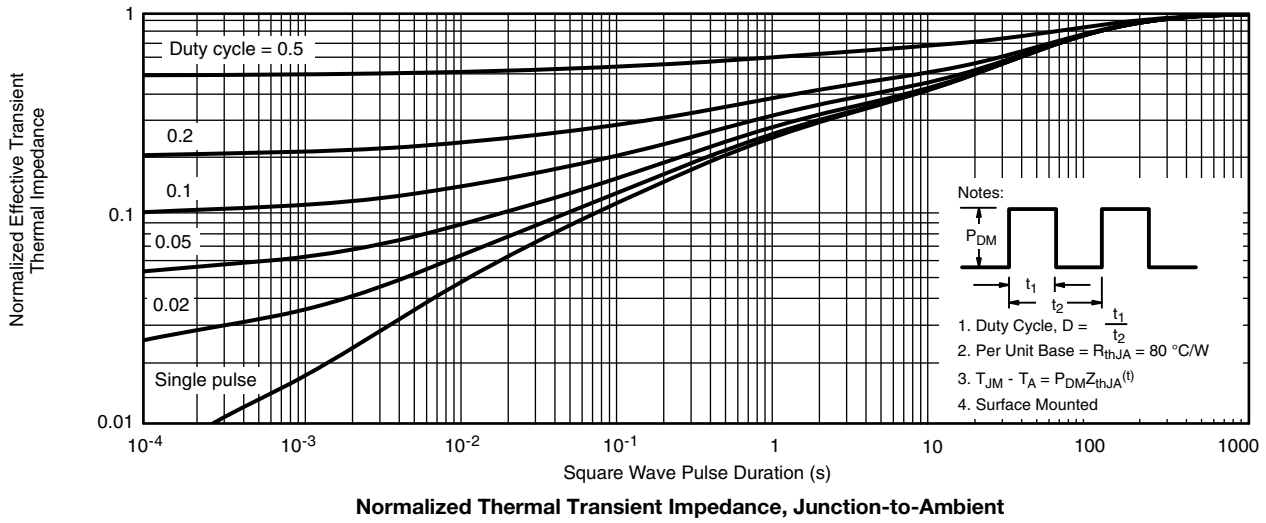


Power, Junction-to-Ambient

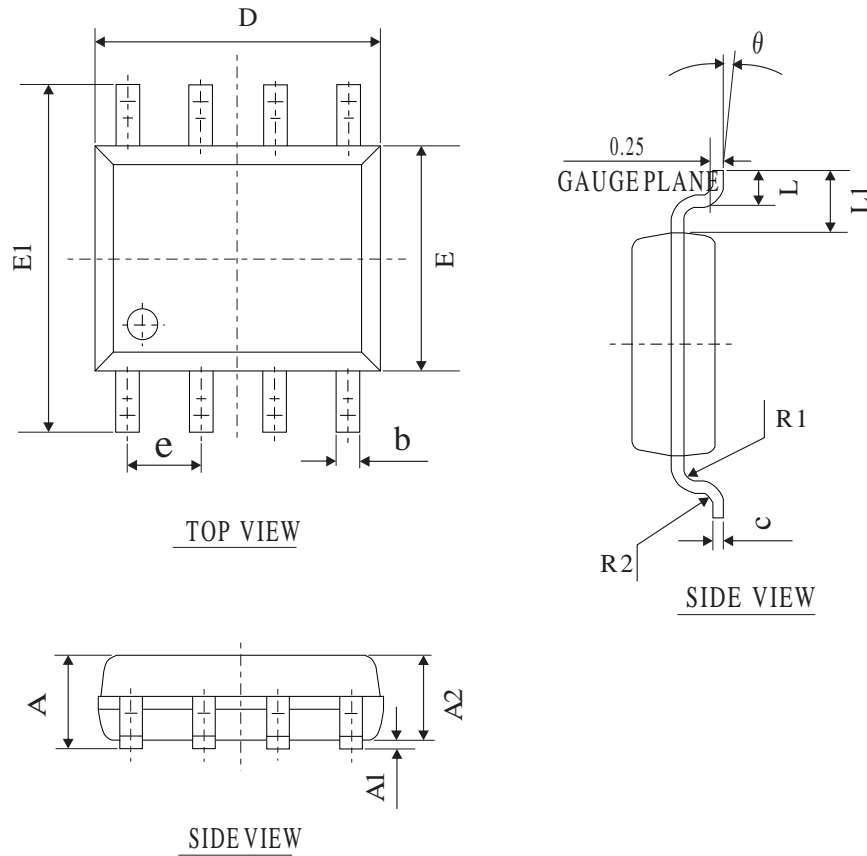
Note

- a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



SOP-8 PACKAGE OUTLINE



COMMON DIMENSIONS
(UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX
A	1.30	1.60	1.85
A1	0.03	0.15	0.28
A2	1.20	1.45	1.70
b	0.26	0.40	0.54
C	0.132	0.203	0.273
D	4.50	4.90	5.30
E	3.50	3.00	4.30
E1	5.50	6.00	6.50
L	0.30	0.70	1.10
θ	2°	4°	6°
L1	1.04REF		
e	1.27BSC		
R1	0.07TYP		
R2	0.07TYP		

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